Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/681,403	CHENG ET AL.		
Examiner	Art Unit		
(Jackie) Tan-Uyen T. Ho	3731		

SEARCHED					
Class	Subclass	Date	Examiner		
			-		
			,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			
		!		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Interference search see attachment	5/8/2006	700		
inventors search see attachement	5/8/2006	100		